



The eGaN[®] FET
Journey Continues

The ZVS Class-D Amplifier, an eGaN[®]
FET-enabled Topology for Highly
Resonant Wireless Power Transfer

Efficient Power Conversion Corporation

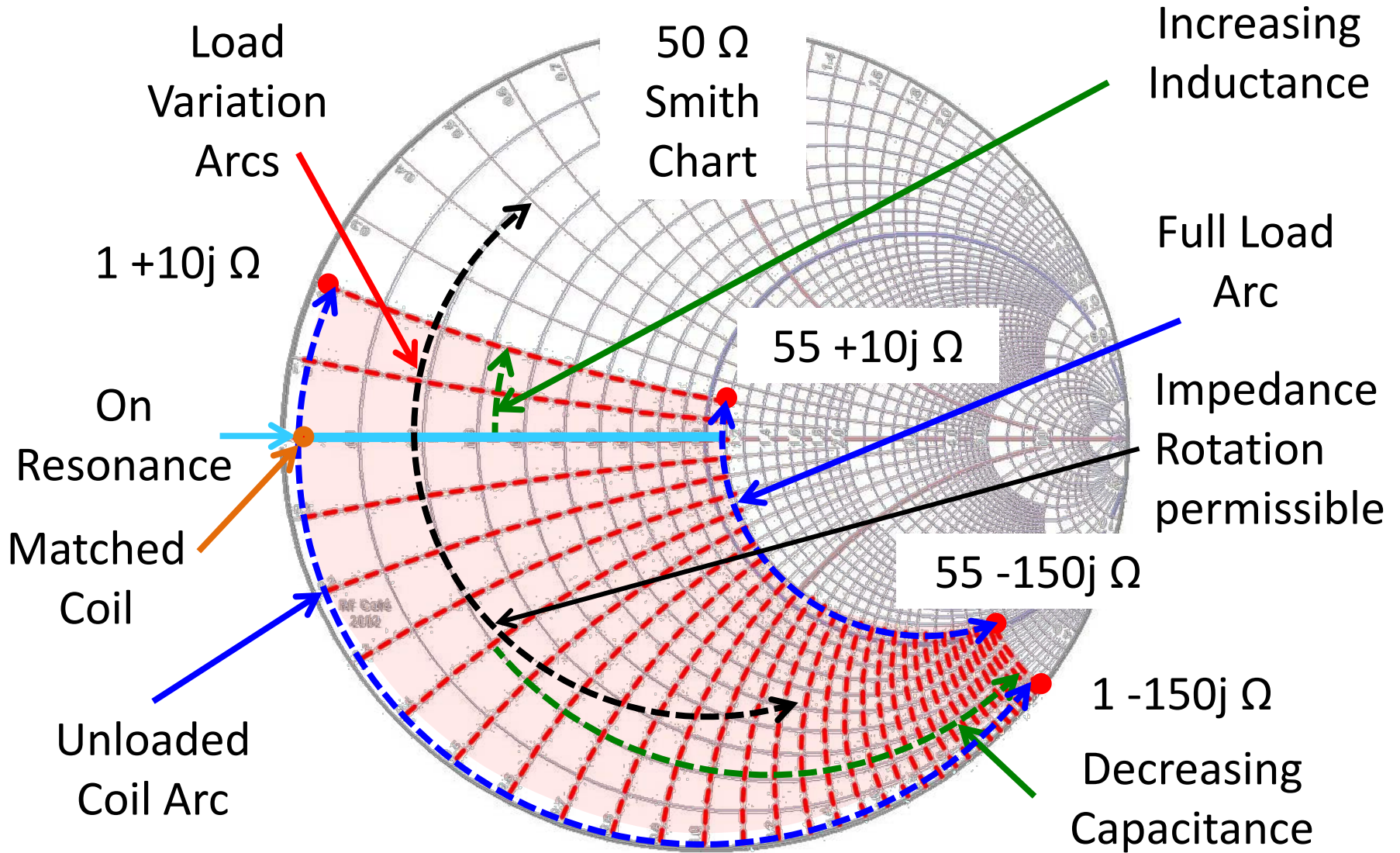
- Introduction to the A4WP Class-3 Specifications
- ZVS Class D Amplifier
- eGaN® FET versus MOSFET Comparison
- Testing to the A4WP Class-3 Specifications
- Experimental Results
- Summary

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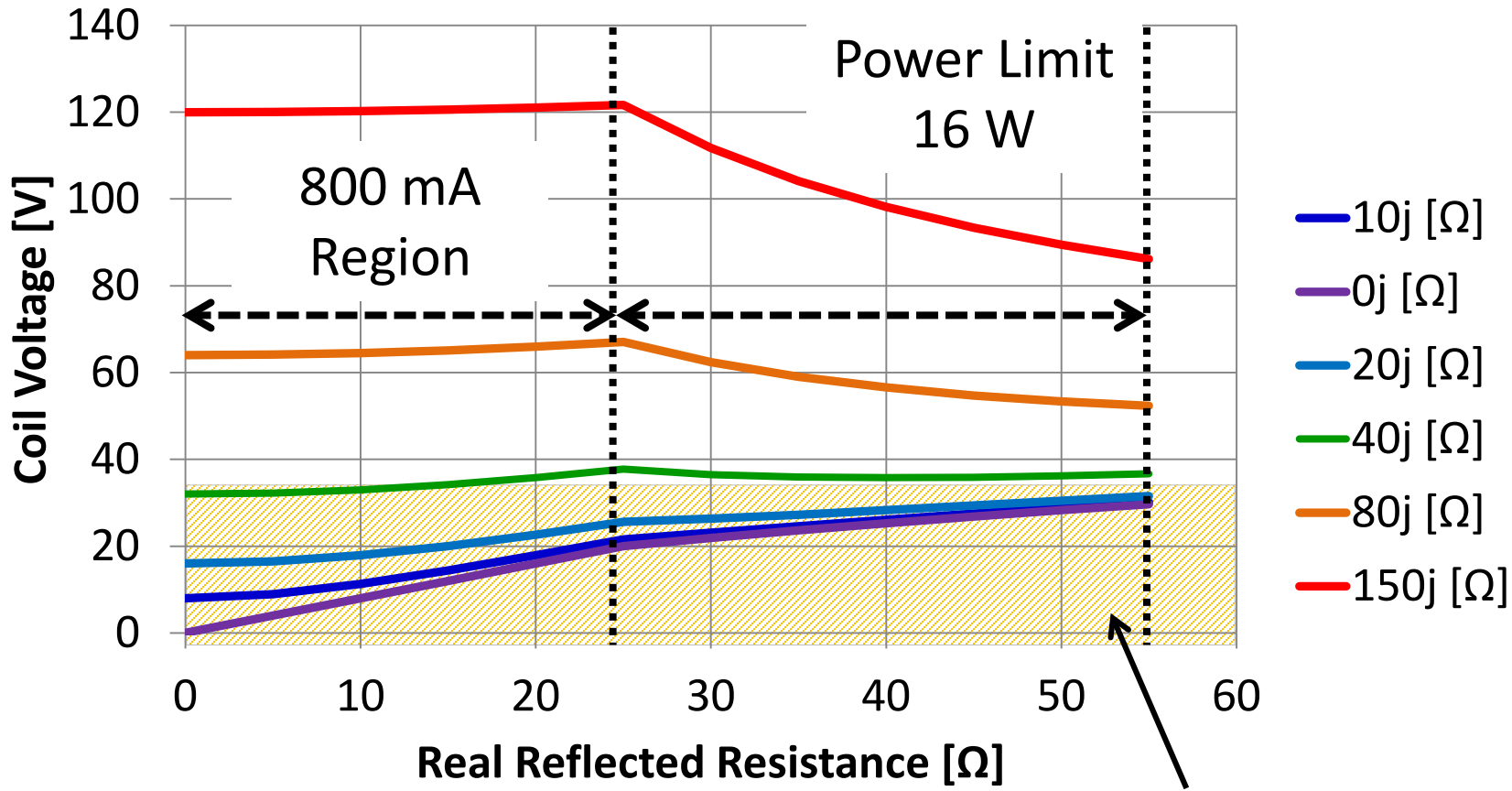
- Wireless power transfer solutions must address convenience-of-use such as:
any device orientation, distance, multiple devices, simplicity, power.
- Only the Alliance for Wireless Power (A4WP / Rezence) standard does:
 - Highly resonant (6.78 MHz ISM band)
 - Loosely coupled coils
 - Operation off-resonance
- ZVS Class D amplifier will be tested to the Class-3 requirements

rezen^{ce}
Alliance for Wireless Power

A4WP Class-3 Impedance Requirements



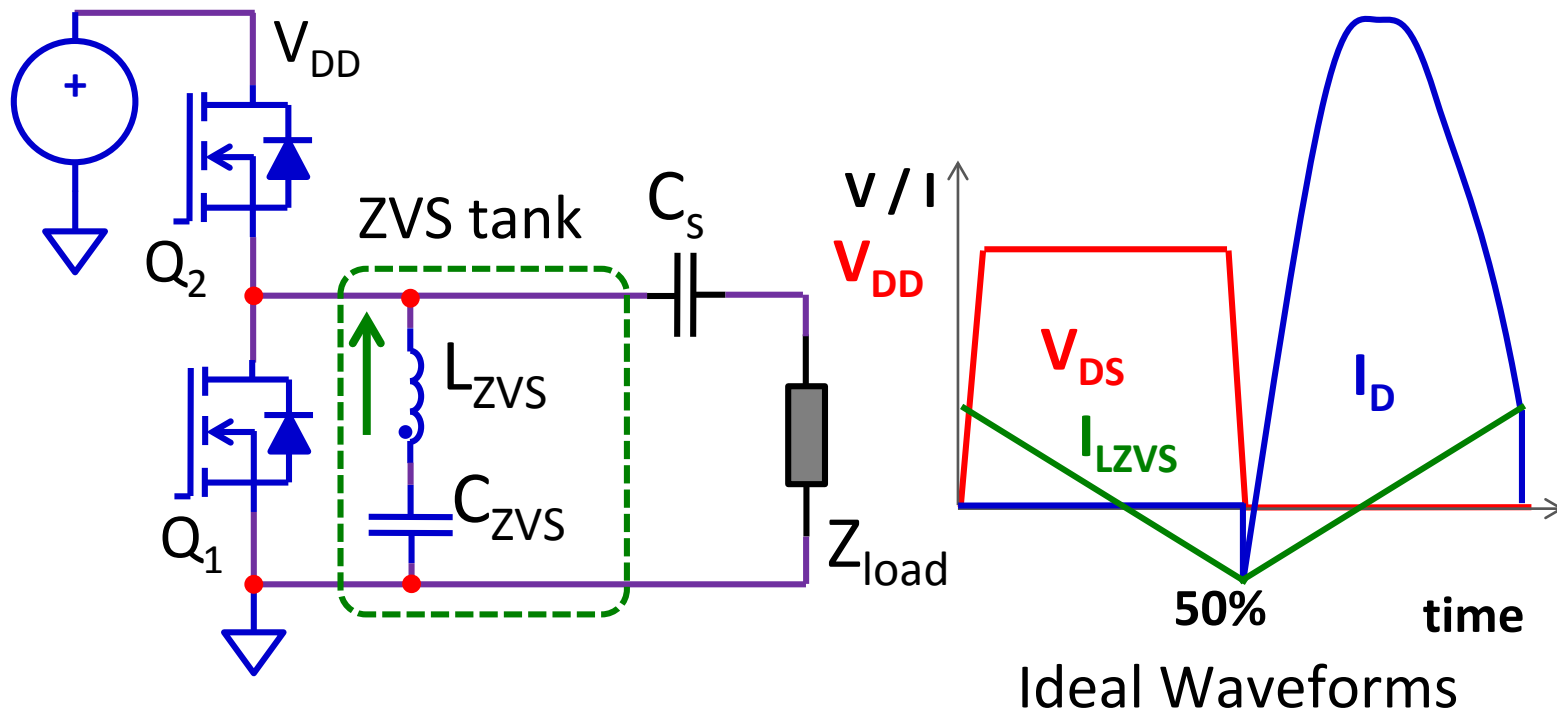
Class-3 Coil Drive Requirements



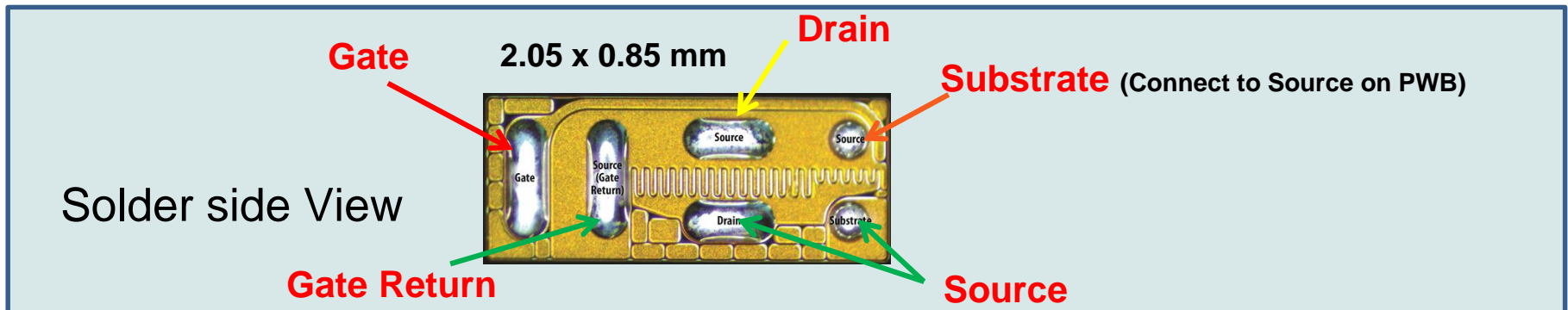
Vector sum of real (R) and imaginary (X) impedance range

Amplifier Limited

- Switch voltage rating = Supply (V_{DD}).
- C_{OSS} Voltage is transitioned by the ZVS tank
- ZVS tank circuit does not carry load current
- Coil Voltage = $(\sqrt{2}/\pi) \cdot V_{DD}$ [V_{RMS}]



- Proven in various wireless power transfer amplifiers
- Low C_{ISS}
- Low C_{OSS}
- Zero Q_{RR}
- Full dv/dt immunity

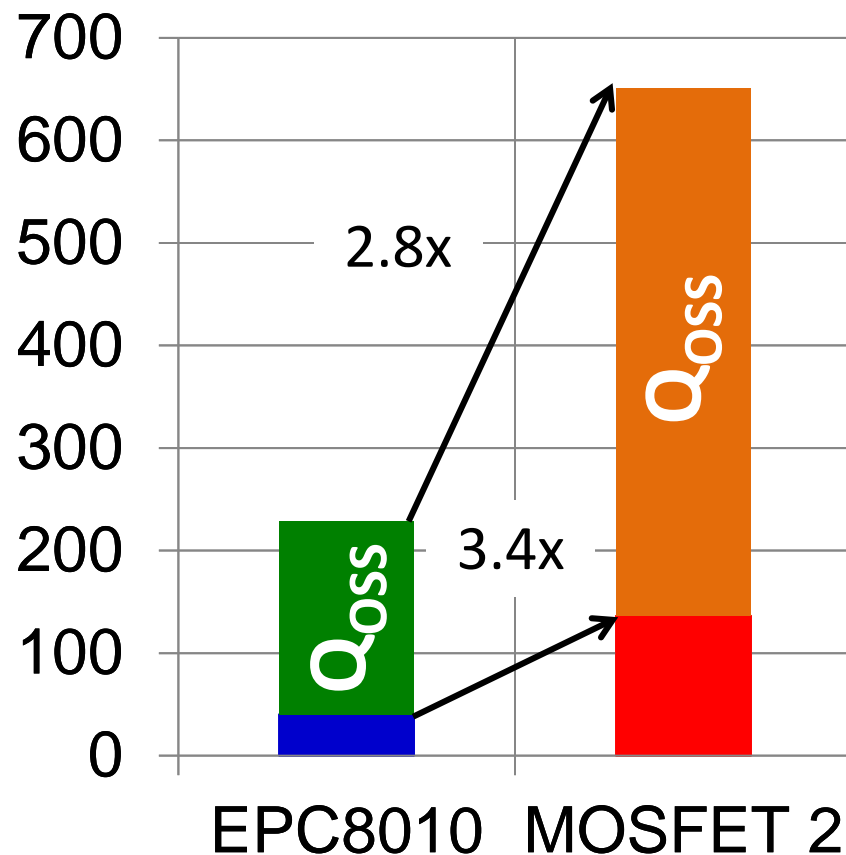


Part Number	Package (mm)	V_{DS} (V)	V_{GS} (V)	$R_{DS(on)}$ @5 V (m Ω)	Q_G @5 V Typ. (pC)	Q_{GS} Typ. (pC)	Q_{GD} Typ. (pC)	R_G Typ. (Ω)	V_{th} Typ. (V)	Q_{RR} (nC)	I_D (A)	T_J Max. ($^{\circ}C$)
EPC8004	LGA 2.05x0.85	40	6	125	358	110	31	0.34	1.4	0	2.7	150
EPC8009	LGA 2.05x0.85	65	6	138	380	116	36	0.3	1.4	0	2.7	150
EPC8010	LGA 2.05x0.85	100	6	160	354	109	32	0.3	1.4	0	2.7	150

Best-In-Class MOSFET comparison

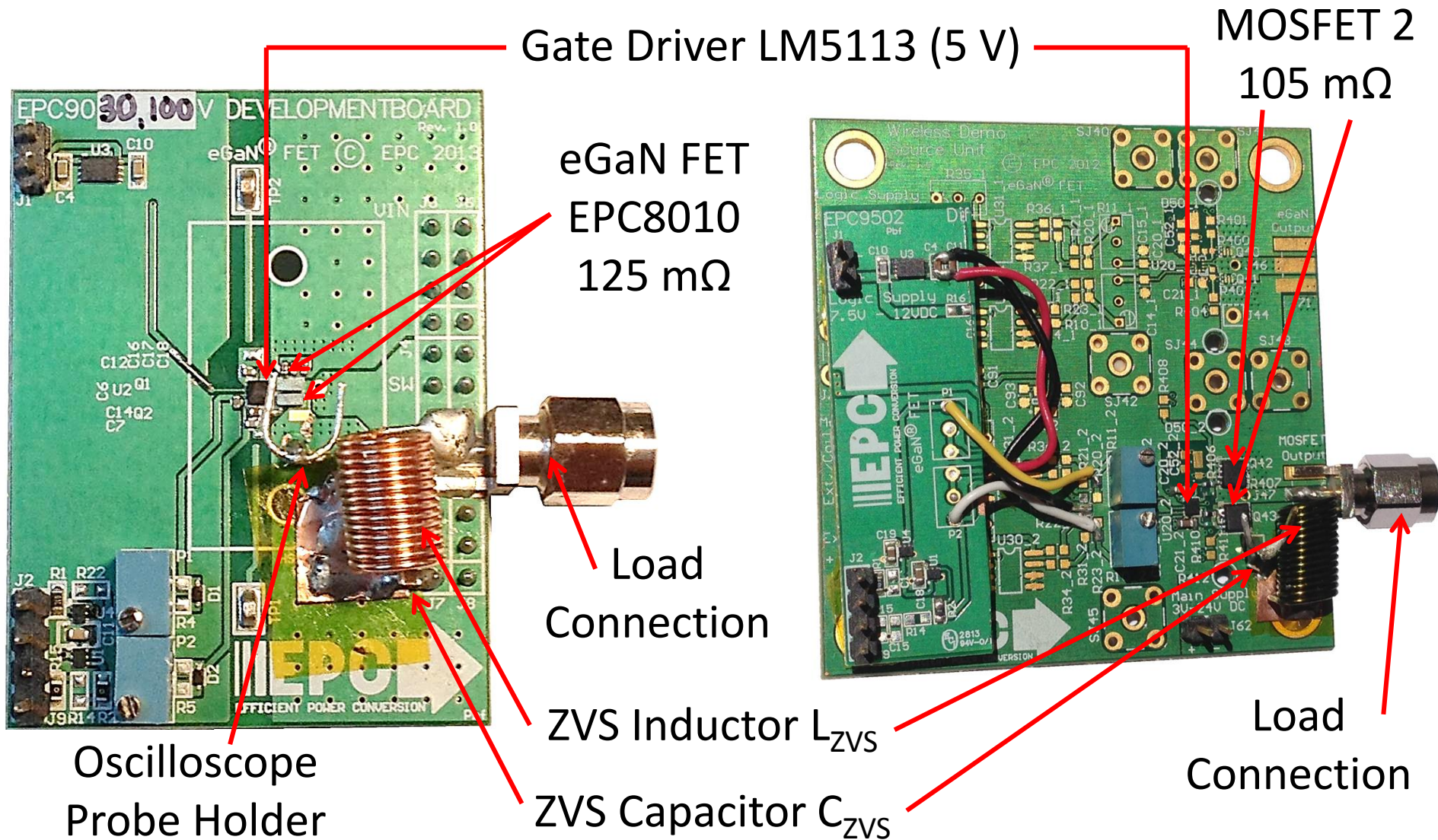
- All topologies are ZVS: $Q_G - Q_{GD}$
- C_{OSS} is “absorbed” in matching but is important as it:
 - Drives off resonance losses
 - Determines design-ability
- Q_{RR} ignored – poorly defined, amplifier is soft switching, BUT, transition time $< t_{RR}$:
 - eGaN FET $Q_{RR} = 0$ nC
 - MOSFET 2 $Q_{RR} = 18.1$ nC !

FoM_{WPT} [$nC \cdot m\Omega$]

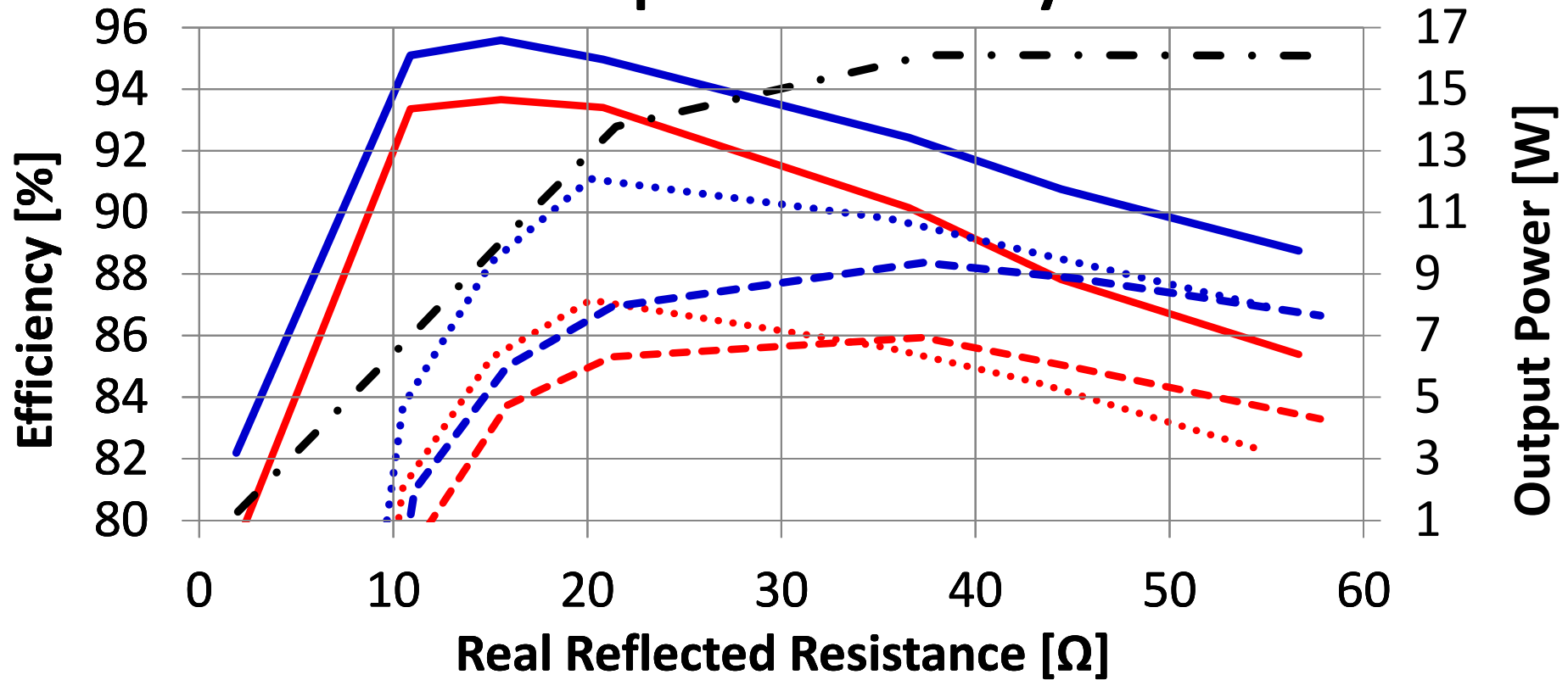


$$FOM_{WPT} = R_{DS(on)} \cdot (Q_G - Q_{GD} + Q_{OSS})$$

Experimental Amplifier

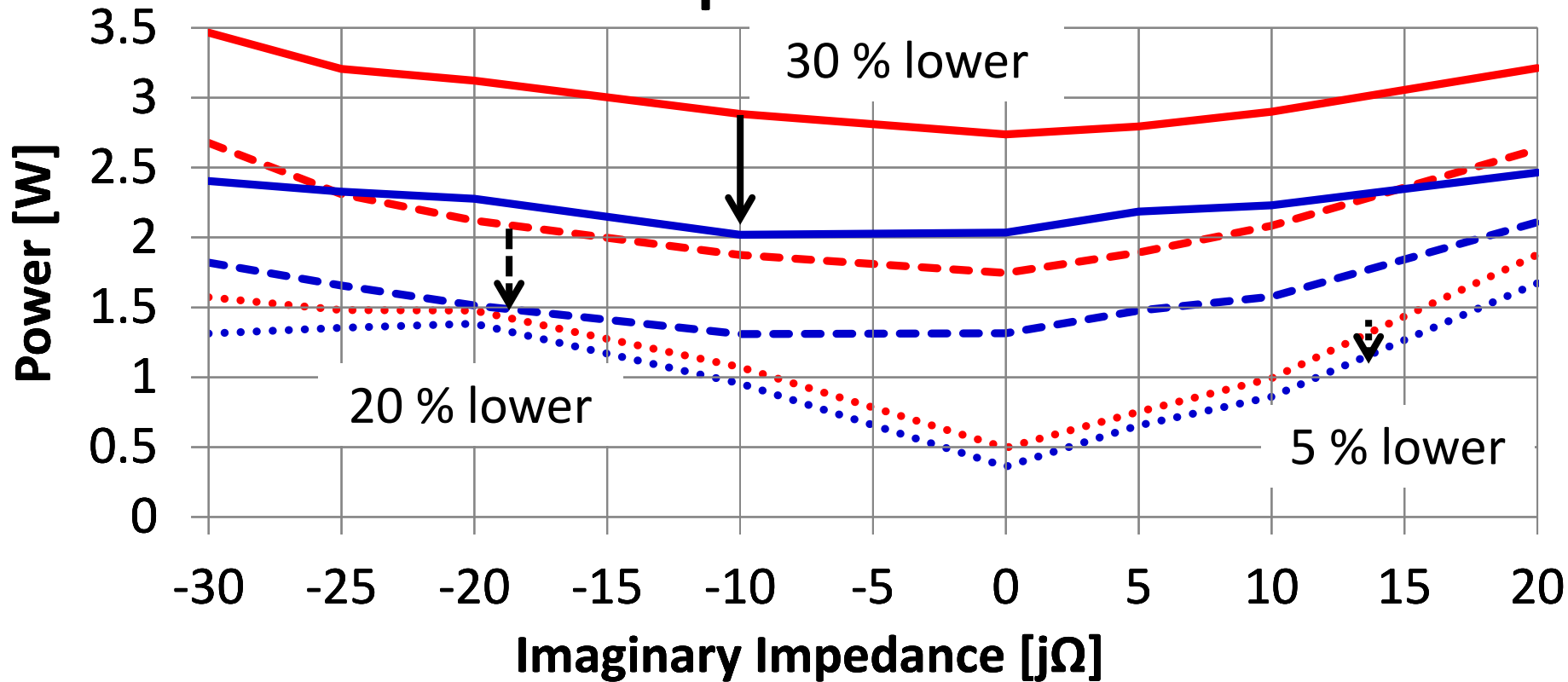


Total Amplifier Efficiency



- EPC8010 -30j Ω
 —— EPC8010 0j Ω
 - - - EPC8010 +20j Ω
- MOSFET -30j Ω
 —— MOSFET 0j Ω
 - - - MOSFET +20j Ω
- . - P_{out}

Total Amplifier Losses



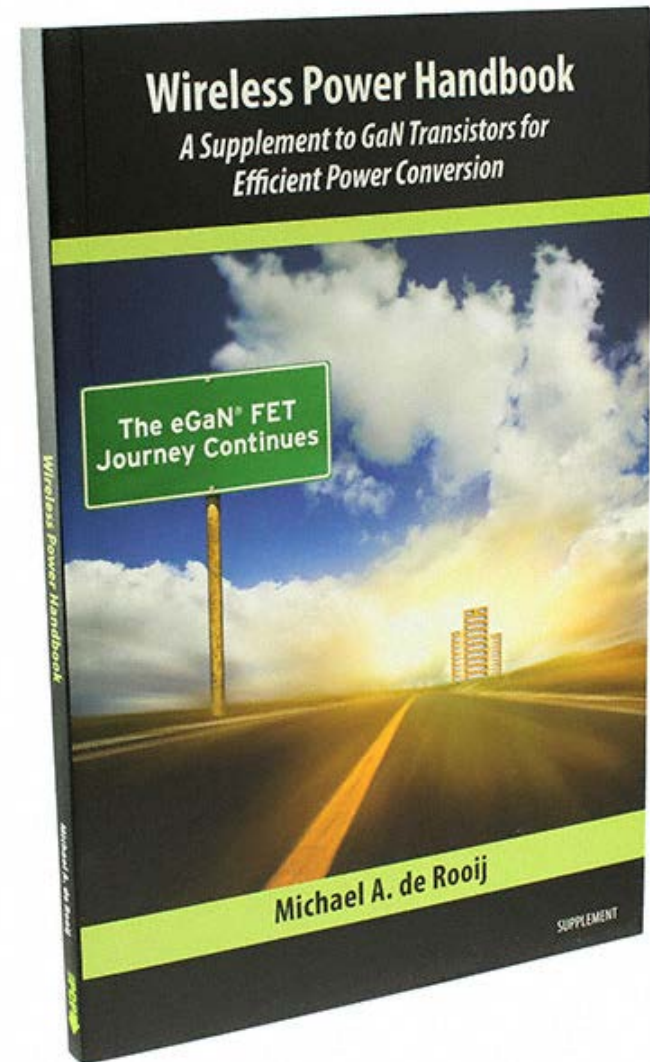
- EPC8010 10 Ω 7 W
- EPC8010 36 Ω 16 W
- EPC8010 55 Ω 16 W

- MOSFET 10 Ω 7 W
- MOSFET 36 Ω 16 W
- MOSFET 55 Ω 16 W

eGaN FETs in a ZVS Class D amplifier were tested to the A4WP Class-3 specifications :

- eGaN FETs always yield higher efficiency than best-in-class MOSFETs
- Gate driver and eGaN FET temperature remain below 100°C
- eGaN FET's lower C_{OSS} reduces the ZVS current needed, resulting in lower power dissipation for both FET and L_{ZVS}
- eGaN FETs reduce board space by 40 %

- Visit EPC's Booth #1405 to see several demonstrations in operation
- Handbook on wireless power that covers this work and much more – available at Digikey



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EFFICIENT POWER CONVERSION

Where is GaN going...

Thank You

